

INVENTOR INFORMATION

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CORRESPONDENCE INFORMATION

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APPLICATION INFORMATION

Title Line One:: SEMICONDUCTOR DEVICE TESTING APPARATUS A
Title Line Two:: ND TEST METHOD THEREFOR
Total Drawing Sheets:: 5
Formal Drawings?:: No
Application Type:: Utility
Docket Number:: A-392
Secrecy Order in Parent Appl.?:: No

REPRESENTATIVE INFORMATION

Representative Customer Number:: 802
Registration Number One:: 35731

PRIOR FOREIGN APPLICATIONS

Foreign Application One:: 2000-113071
Filing Date:: 04-14-2000
Country:: JAPAN
Priority Claimed:: Yes

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